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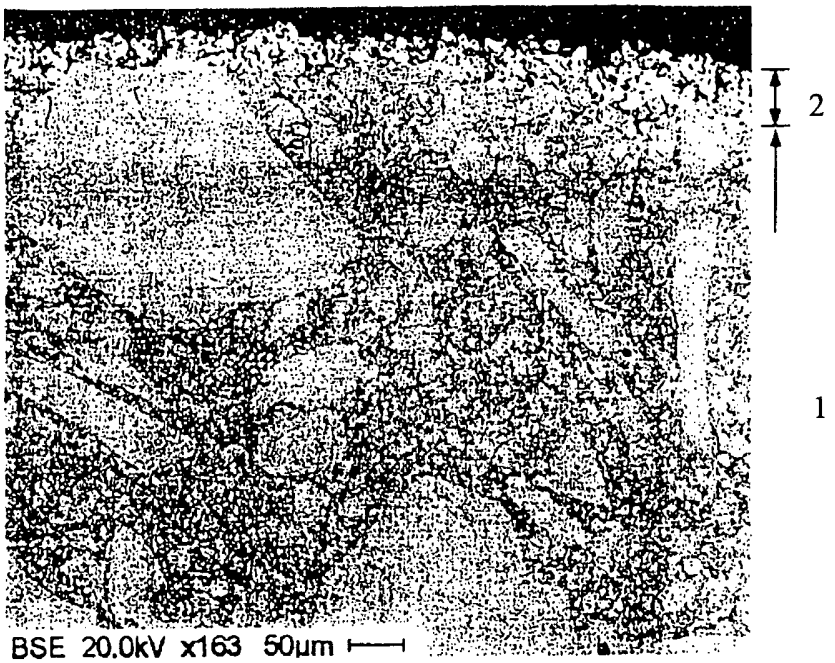
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[Continued on next page]

(54) Title: VESSEL FOR HOLDING SILICON AND METHOD OF PRODUCING THE SAME



(57) Abstract: The invention relates to a vessel for holding a silicon molten bath which can effectively prevent contamination of a silicon melt solution and have excellent sinterability, mechanical strength and productivity. The interior of the vessel is formed with a sprayed coating by spraying a silicon composite thermet consisting of metal silicon (MSi), silicon nitride (Si_3N_4) and silicon oxide (SiO_2).

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Declaration under Rule 4.17:

— *as to applicant's entitlement to apply for and be granted a patent (Rule 4.17(ii)) for the following designations AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NO, NZ, OM, PH, PL, PT, RO, RU, SD, SE, SG, SK, SL, TJ, TM, TN, TR, TT, TZ, UA, UG, UZ, VN, YU, ZA, ZM, ZW, ARIPO patent (GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, IE, IT, LU, MC, NL, PT, SE, SI, SK, TR), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG)*

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Vessel for holding silicon and method of producing the same

[0001] This invention relates to a vessel for melting silicon or a vessel for holding molten silicon and a method of producing the same.

[0002] The vessel according to the invention includes a mold made of sintered fused silica which is used for producing a semiconductor silicon wafer or a polycrystal silicon wafer for generating power from sunlight and for casting a silicon ingot, or a sintered fused silica crucible for melting, cleaning and further carrying silicon to a foundry, and moreover a vessel for holding a silicon bath until it is injected.

[0003] Hitherto, in the field of producing semiconductors, it is common to produce a silicon wafer as the base of a semiconductor element by solidifying a high purity silicon melt solution, forming a silicon monocrystal and slicing it. For example, a pure silicon material is melted by a heating resistance, a high frequency inductive heating device and the like, the silicon melt solution is then seeded with crystals. The solution is thoroughly mixed and then drawn up slowly and unidirectionally solidified to form a large cylindrical silicon monocrystal having preferred orientation of the seed crystal. In such a producing process, graphite, quartz, boron nitride and platinum are suitable materials for the vessel for melting and holding silicon, (i.e., the crucible).

[0004] Moreover, in case of producing amorphous silicon or polycrystal silicon for a solar cell, it is necessary to hold a very pure silicon melt solution within a vessel such as the above-described crucible.

[0005] As described above, however, when a crucible is used as a vessel for holding molten metal, the silicon melt solution is often contaminated with impurity metal components of the crucible walls contacting the molten bath, thereby reducing the purity of the silicon.

[0006] Further, with a background of offering cheap silicon and demanding productivity improvement in recent years, a cheap fused silicon oxide material (sintered or densified fused silica) has largely been used instead of quartz for the crucible, and measures to avoid the contamination of a silicon melt solution have been required.

[0007] In reply to such requirement, hitherto, as the measures to avoid the contamination of the silicon melt solution, there has been considered a method of applying a coating to the melt solution contact portion of a sintered silicon oxide material crucible so as to protect the silicon melt solution from direct contact with the crucible walls. I.e., the inside of the crucible wall is coated with a coating agent such as an oxide, a nitride and the like having an excellent releasability from molten silicon

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and an excellent wettability with the molten silicon (the more wettable is the coating, the less deep is the molten silicon penetration).

[0008] However, as the said coating agents (oxide, nitride) are hardly sintering by themselves, there are defects such as weak bond strength to the crucible wall and partial peeling. Further, the peeled coating agent is mixed into the molten silicon and forms new impurities, lowering again the purity of the product.

[0009] On the other hand, as a coating agent, use may be made of silicon nitride (Si_3N_4), which is well known as a material having excellent non-reactivity with molten silicon because it includes no metal element. However, silicon nitride is poor in sinterability and worse in productivity since shaping-sintering treatments such as hot press, HIP and the like are not available for bringing the mechanical strength up to a practical level. Further, there is a problem of large economical loss when applying the aforesaid treatments for a crucible which is regarded as expandable.

[0010] I.e., the higher the demand for purity, the higher the requirement for high performance of the chemical composition of the coating agent itself, the mechanical strength of a coating layer per se and the bonding strength to the crucible wall. Further, prior technique for applying the above coating layer is slow in film-forming rate and requires many layers to obtain a practical thickness. Therefore, it needs to be improved in terms of productivity and cost.

[0011] As described above, when a crucible, is used as a vessel, for producing a silicon wafer, it is necessary to protect the silicon melt solution from contamination with impurity from the crucible wall so as to obtain silicon of high purity. Therefore, heat-resistant coatings such as oxide, nitride and the like are often applied to the inner surface of the crucible to avoid any contamination, but as discussed above, these coating materials are generally poor in sinterability and low in mechanical strength, and requires to be improved in the light of productivity and economy.

[0012] A main object of the invention is therefore to solve the aforesaid problems of the prior art, that is, to provide a silicon molten bath holding vessel which will not contaminate the silicon melt solution together with excellent sinterability, mechanical strength and productivity.

[0013] Further, another object of the invention is to provide such sprayed coating forming technique, such that the silicon molten bath little reacts with the molten bath contact surface of the molten silicon holding vessel, erosion resistance is excellent against a flow in the molten bath, metal contamination is low, and an ingot of high quality and high yield can effectively be obtained.

[0014] The invention provides a silicon holding vessel basically made by coating a

silicon composite thermet sprayed coating consisting of metal silicon, silicon nitride and silicon oxide on the interior of the silicon holding vessel. In such construction, the said silicon composite thermet sprayed coating plays a role of non-reactivity of a nitride against molten silicon, and shows good erosion resistance against a melt solution flow by mutually compounding a glass bonding phase of an oxide compounded with the nitride and a metal silicon bonding phase.

[0015] Further, in the invention, the said silicon composite thermet sprayed coating is preferably formed by spraying a silicon composite thermet material made by adding metal silicon as a bonding agent to a mixture of Si_3N_4 and SiO_2. Further, the silicon holding vessel is made by using either one of silicon oxide, boron nitride and graphite, in which the silicon oxide (SiO_2) is preferably densified fused silica.

[0016] Further, the invention relates to a method of producing a silicon holding vessel, which comprises spraying a silicon composite thermet material consisting of metal silicon, silicon nitride and silicon oxide on the interior of the silicon holding vessel, thereby forming a silicon composite thermet sprayed coating.

[0017] Moreover, in the invention, the said silicon holding vessel is preferably formed in a material comprising silicon oxide, boron nitride and/or graphite. The said sprayed coating is preferably coated and formed by any spraying process such as plasma spraying, high velocity gas flame spraying, gas powder spraying or detonation spraying.

[0018] Moreover, according to the invention, the above silicon composite thermet sprayed coating preferably has a mixing ratio of metal silicon (X), silicon nitride (Y), silicon oxide (Z) of X:Y:Z = 20-50: 77-30: 3-20.

[0019] Brief description of the drawing

Fig. 1 is a photomicrography of the sectional structure of the composite sprayed coating of the invention.

[0020] The inventors have examined the sprayed coating of hardly sinterable silicon nitride for many years. As a result, the inventors ascertained that it is effective to use a silicon composite thermet material (mixed raw material) obtained by mixing silicon nitride with silicon oxide and metal silicon at a predetermined ratio. According to the preferred process of the invention, the surface of the vessel is first cleaned, the said silicon composite thermet material is then sprayed to form a silicon thermet sprayed coating, and thereafter optionally, if it is desirable to adjust the smoothness of the surface, the coated surface can be polished.

[0021] According to the prior art, in order to use Si_3N_4 as industrial material, it is necessary to form a layer by hot pressing or HIP, by adding a sintering aid. In case of

forming a sprayed coating with the use of inorganic nonmetal material such as oxide, carbide, boride or nitride, an addition of metal as a binder is fundamental. According to the invention, however, as the object thereof is a vessel for melting and holding high purity silicon, it is considered to be inappropriate to use a metal different from the silicon. Therefore, since the high purity material to be treated is silicon, the invention uses high purity silicon as a binder.

[0022] Further, the invention adds a silicon oxide besides the use of metal silicon as a binder. The reason why silicon oxide is used in the invention is that a sprayed coating composite thermet including silicon nitride and oxide using metal silicon as a matrix (binder layer) is obtained by softening the silicon oxide (SiO_2) in a plasma flame during plasma spraying, envelopingly adhering at least part of Si_3N_4, further coveringly adhering both Si_3N_4 and SiO_2 to the said metal silicon and flying as fixing and making Si_3N_4 particles pseudo-particles. Such sprayed coating has a very high strength.

[0023] The above spraying material (raw material powder) is made by mixing metal silicon $(MSi)_x$, silicon nitride $(Si_3N_4)_y$ and silicon oxide $(SiO_2)_z$ at the following mixing ratio (capacity ratio)

X:Y:Z = 20-50: 77-30: 3-20.

[0024] At the above mixing ratio of each component, the reason why $(MSi)_x$ is limited to 20-50 is because an amount of less than 20 is not sufficient to work as a binder between oxide and nitride to obtain a coating strength, and as a result, it does not withstand erosion loss caused by moving contact with a melt solution. An amount of more than 50 provides large silicon metal zone in the coating, so that a diffuse reaction layer of the coating and the melt solution is formed until solidification of the melt solution, and, therefore, a layer containing impurities on the solidified product surface is formed. The preferable amount is 30-45.

[0025] Further, The reason why $(SiO_2)_x$ is limited to 3-20 is because when it is less than 3, binding strength between Si_3N_4 particles cannot be obtained, and when it is more than 20, the wettability of Si_3N_4 by the melt solution is prevented. The preferable amount is 7-13.

[0026] $(Si_3N_4)_y$ is determined by optimizing the amount of the above $(M\ Si)_x$ and $(SiO_2)_z$ taking into account the desired coating strength and melt solution wettability.

[0027] Further, it is preferable to use silica (densified fused silica) for SiO_2. As industrial SiO_2 material, there are fused silica as an opaque substance using silica sand as raw material and vitreous silica as a transparent substance produced by using crystal as raw material, both of which can be used in the present use as far as

properties of matter are concerned. However, the reason why according to the invention the use of densified fused silica is preferable is because a densified fused silica product can be formed as required form by melting silica sand to obtain rough raw material consisting essentially of SiO_2, thereafter pulverizing to form fine particles, and further molding into a mold, and further sintering the mold to impart the mechanical strength necessary for the product. The product made with such densified fused silica material has excellent compatibility and sizability.

[0028] The above spraying material is sprayed on at least the surface of a part contacted with molten metal within a holding vessel in a thickness of about 20-500 μm, preferably 40-300 μm. The reason why the coating thickness is limited in this manner is because if the thickness is thinner than 20 μm, it is insufficient to form a coherent layer between thermet particles and there is the possibility for the melt solution to contact the crucible base material through gaps, while if the thickness is thicker than 500 μm, the risk of peeling the coating is increased.

[0029] Example

This example uses mixed powder of metal silicon and SiO_2 with Si_3N_4 having the following composition by spraying silicon composite thermet material as a coating layer formed on the surface of a silicon holding vessel.

[0030] Table 1

Composition	
oxygen	under 0.2 mass %
carbon	under 0.2 mass %
chlorine	under 100 ppm
He	under 100 ppm
Al,Ca	traces
Si_3N_4	the remaining

[0031] There are used metal silicon of 99.9% purity and SiO_2 of 99.8% purity. The mixture ratio of these raw material powders is $Si:Si_3N_4:SiO_2$ = 40:50:10. Further, the mixed powder is converted into a thermal spray material by previously granulating into about 25,3 μm in mean particle diameter.

[0032] Fig. 1 shows the sectional structure of a composite sprayed coating according to the invention. The illustrated reference numeral 1 shows a densified fused silica base material and 2 a composite sprayed coating.

[0033] Example 1

In this example, the interaction between a densified fused silica base material covered with a silicon composite thermet sprayed coating and a silicon melt solution according to the invention is examined. As a probe, use is made of a densified fused silica base material of dimension: 100x50x6 mm. On the probe surface is sprayed a spraying material mixed at the ratio of $Si:Si_3N_4:SiO_2$ = 40:50:10 in thickness of 300 μm by an atmospheric plasma spraying process to form a silicon composite thermet sprayed coating. The erosion resistant property of the coating due to melt solution falling and the influence of the melt solution contact are examined by laying such probe formed with the sprayed coating at the bottom of a crucible made of densified fused silica of 350x350x400 (h)mm in size and injecting a silicon melt solution from the upper part. The crucible is heated from the outside with the use of an electric heater and held in the molten state of the silicon melt solution for 3 hours.

[0034] After 3 hours, the specimen is taken out of the crucible and the surface is observed. Within a visual observation, no peeling from the coating base material is recognized and, good bondability and non-reactivity are shown. Further, there is found no influence of the melt solution on the coating.

[0035] Example 2

In this example is formed a silicon composite sprayed coating according to the invention on the interior of a polycrystalline silicon ingot cast mold in order to produce a solar cell polycrystalline silicon wafer used for sunlight power generation. The mold used is made of densified or sintered fused silica containing Al_2O_3:2000 ppm and Fe_2O_3:200 ppm, and its dimension is 350x350x400 (h)mm. On the bottom of the mold is sprayed a spraying material powder raised at the capacity ratio of $Si:Si_3N_4:SiO_2$ = 40:50:10 in thickness of 50-70 μm by an atmospheric plasma spraying process to form a silicon composite thermet sprayed coating.

[0036] As a comparative example, there is used a coating formed by slurrying Si_3N_4 powder with the use of polyvinyl alcohol as a solvent, brushing the resulting slurry on the mold base or applying by a spraying process and firing at 900°C.

[0037] Table 2 shows a result after examining contamination due to different kinds or materials at the surface layer portion of a silicon ingot product after casting.

[0038] Table 2

	Crucible Coating Material	Different material detected	
		Component	Depth from ingot surface layer
Example of the invention	Si_3N_4/ SiO_2/Si plasma sprayed film (50-70 μm)	SiO_2	several μm
Comparative example	Applied fired coating of Si_3N_4 slurry (500-1500 μm)	Si_3N_4, Al_2O_3, SiO_2, Fe_2O_3	several 100 μm

[0039] As is clear from the result of table 2, in the example of the invention, the different material detected in the silicon ingot surface layer is SiO_2 only. Further, the penetrated depth from the surface layer is several μm. This SiO_2 is due to atmospheric oxidation of Si. Therefore, this SiO_2 can completely be removed by bevel cutting at not more than 2mm. As a result, the ingot yield is not less than 98%.

[0040] On the contrary, in comparative example, besides Si_3N_4, Al_2O_3, SiO_2, Fe_2O_3 and the like are further detected on the surface layer. Particularly, as metal elements, Al and Fe are observed, and the penetrated depth from the surface layer of the different material is several 100 μm. In order to remove these different materials detected on the surface layer, it is necessary to bevel cut both sides in thickness of 10 mm, and the yield of a product ingot as low as about 94%.

[0041] According to the invention as explained above, in a crucible for casting metal silicon required to be highly pure, on the molten bath contact surface of the crucible is sprayed silicon composite thermet spraying material consisting of $Si/Si_3N_4/SiO_2$, thereby forming a coating to prevent the densified fused silica crucible from direct contact with the melt solution, to dissolve contamination due to crucible material and to form a strong releasable functional layer as compared with the hitheto used Si_3N_4 single coated layer. As a result, it can be possible to aim at the product yield improvement of a highly pure silicon ingot.

Claims

1. A silicon holding vessel comprising a silicon composite thermet sprayed coating comprising metal silicon, silicon nitride and silicon oxide on at least a part of the interior wall of the silicon holding vessel.

2. A vessel according to claim 1, **characterized in that** the silicon composite thermet sprayed coating is formed by spraying a silicon composite thermet material made by adding metal silicon as a bonding material to a mixture of Si_3N_4 and SiO_2.

3. A vessel according to claim 1 or 2, **characterized in that** the silicon composite thermet sprayed coating has a mixing ratio of metal silicon (X): silicon nitride (Y): silicon oxide (Z) of X:Y:Z: = 20-50: 77-30: 3-20.

4. A vessel according to claim 1 or 2, **characterized in that** the silicon holding vessel is made from a material comprising silicon oxide, boron nitride and/or graphite.

5. A vessel according to claim 4, wherein the silicon oxide (SiO_2) is densified or sintered fused silica.

6. A vessel according to claim 1, **characterized in that** the coating has a thickness of 20-500 µm, preferably of 50-300 µm.

7. A method of producing a silicon holding vessel, which comprises spraying a silicon composite thermet material consisting of metal silicon, silicon nitride and silicon oxide on the interior wall of a silicon holding vessel, thereby forming a silicon composite thermet sprayed coating.

8. A method according to claim 7, wherein the silicon holding vessel is made from a material comprising silicon oxide, boron nitride and/or graphite, preferably densified or sintered fused silica.

9. A method according to claim 7, wherein the silicon thermet sprayed coating has a mixing ratio of metal silicon (X): silicon nitride (Y): silicon oxide (Z) of X:Y:Z: = 20-50: 77-30: 3-20.

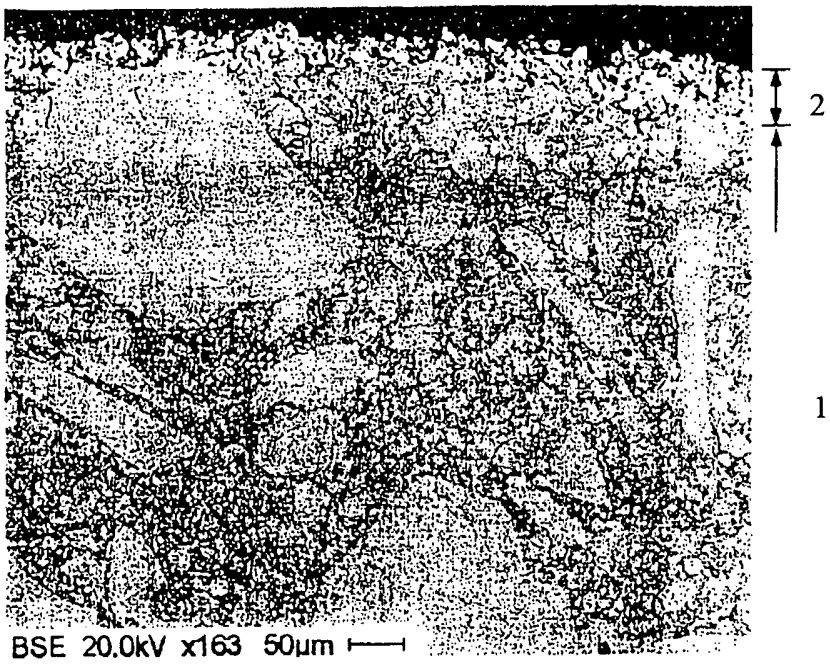


Fig. 1

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PCT/EP (PCT/EP2002/013850

A. CLASSIFICATION OF SUBJECT MATTER
IPC 7 C30B15/10 C30B11/00 C30B35/00 C04B41/87

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)
IPC 7 C30B C04B

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

PAJ, EPO-Internal

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category °	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
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A	" ABSTRACTS + INDEXES, AMERICAN CHEMICAL SOCIETY. COLUMBUS, US" CHEMICAL ABSTRACTS + INDEXES, AMERICAN CHEMICAL SOCIETY. COLUMBUS, US, vol. 105, no. 4, 28 July 1986 (1986-07-28), XP000185916 ISSN: 0009-2258	1
A	& JP 61 048491 A 10 March 1986 (1986-03-10)	

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[X] Further documents are listed in the continuation of box C.

[X] Patent family members are listed in annex.

° Special categories of cited documents :

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Date of the actual completion of the international search	Date of mailing of the international search report
27 August 2003	08/09/2003

Name and mailing address of the ISA	Authorized officer
European Patent Office, P.B. 5818 Patentlaan 2 NL – 2280 HV Rijswijk Tel. (+31–70) 340–2040, Tx. 31 651 epo nl, Fax: (+31–70) 340–3016	Cook, S

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INTERNATIONAL SEARCH REPORT

Internati[redacted] Application No
PCT/EP 02/13850

C.(Continuation) DOCUMENTS CONSIDERED TO BE RELEVANT

Category °	Citation of document, with indication,where appropriate, of the relevant passages	Relevant to claim No.
A	HIDE ET AL.: "Mould shaping silicon crystal growth with a mould coating material by the spinning method" JOURNAL OF CRYSTAL GROWTH., vol. 79, no. 1-3, December 1986 (1986-12), pages 583-589, XP002252583 NORTH-HOLLAND PUBLISHING CO. AMSTERDAM., NL ISSN: 0022-0248 ---	
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Information on patent family members

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PCT/EP 02/13850

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